

Form PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				ATTY. DOCKET NO. AOK-05-1161		SERIAL NO. <b>107539143</b>		
LIST OF PUBLICATIONS CITED BY APPLICANT <small>(Use several sheets if necessary)</small>				APPLICANTS Ken Nakamura et al.		GROUP <b>1772</b>		
				FILING DATE Herewith				
<b>U.S. PATENT DOCUMENTS</b>								
EXAMINER INITIAL*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA							
	AB							
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<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL	JP 5-293916 A	11/09/93	Japan				
	AM	JP 8-127089 A	05/21/96	Japan				
	AN	JP 10-24505 A	01/27/98	Japan				
	AO	JP 10-95075 A	04/14/98	Japan				
	AP	JP 10-95083 A	04/14/98	Japan				
	AQ	WO 00/23506 A	04/27/00	PCT				
	AR	WO 00/16862 A	12/21/00	PCT				
	AS	EP 1122060 A	08/08/01	Europe				
	AT	WO 01/094110 A	12/13/01	PCT				
	AU	WO 02/00026 A	01/03/02	PCT				
	AV	EP 1333052 A	08/06/03	Europe				
<b>OTHER PUBLICATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AW							
	AX							
	AY							
EXAMINER <i>M. B. Giff</i>				DATE CONSIDERED <b>6/18/07</b>				
*EXAMINER: Initial if publication considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.								

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Sheet 1 of 1

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FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL	JP 60-14695 B2	4/15/85	Japan				
	AM	JP 61-283523 A	13/12/86	Japan				
	AN	JP 10-156978 A	6/16/98	Japan				
	AO	JP 58-210738 A	12/22/83	Japan				
	AP	JP 9-39176 A	2/10/97	Japan				
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EXAMINER <i>Mark Blyth</i>	DATE CONSIDERED <i>6/18/07</i>
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